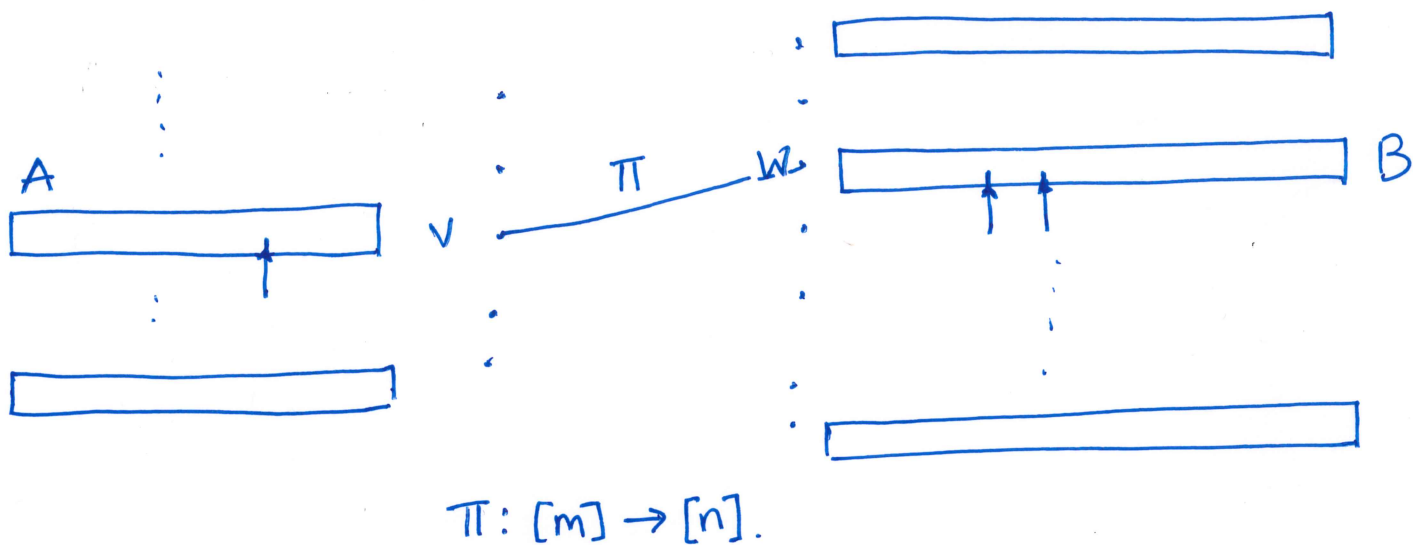


Håstad's 3-Bit PCP: Final Construction

Gap_{1,δ} L(G(v,w,E), [n], [m], {π_{vw}})



- Expect as a proof, $\forall v, w$

Long code of $l(v)$ $1 \leq l(v) \leq n$

Long code of $l(w)$ $1 \leq l(w) \leq m$.

Test

- Pick edge (v,w) at random. $\pi = \pi_{vw}$.

- Let $A =$ Supposed Long code of $l(v)$.

$B =$ Supposed Long Code of $l(w)$.

- Run Consistency Test (A, B, π) .

(With noise ϵ).

Completeness

- $\text{OPT}(\mathcal{L}) = 1.$
- $\ell: V \rightarrow [n], \ell: W \rightarrow [m]$ labeling.
- $\forall (v, w) \in E, \quad - \pi(\ell(w)) = \ell(v)$
- A, B be correct long codes.
- $\Pr[\text{Consistency test acc}] \geq \underline{\underline{1-\epsilon}}$.

Soundness

If $\Pr[\text{verifier acc}] \geq \frac{1}{2} + \eta$ then we show that \mathcal{L} has a labeling that satisfies $\Omega(\epsilon^1 \eta^3 \log^{-1}(1/\eta))$ fraction of its edges. If $\text{OPT}(\mathcal{L}) \leq \delta \ll \eta$, contradiction. (and hence $\Pr[\text{verifier accepts}] \leq \frac{1}{2} + \eta$.)

Proof

- Suppose $\Pr[\text{verifier acc}] \geq \frac{1}{2} + \eta$
- By "averaging argument," for $\geq \frac{\eta}{2}$ fraction of edges (v, w) , Consistency Test (A, B, π) accepts w.p. $\geq \frac{1}{2} + \frac{\eta}{2}$.

∴ For every such "good" edge

$$\sum_{\alpha \subseteq \pi(\beta)} \hat{A}_\alpha^2 \hat{B}_\beta^2 \geq \frac{\eta^2}{4} \quad \text{--- } \textcircled{\#1}$$

$$|\beta| \leq \frac{1}{\epsilon} \cdot \log\left(\frac{1}{\eta}\right).$$

consider the following labeling. (probabilistic).

For V:

- Consider table A.
- Pick $\alpha \subseteq [n]$ w.p. \hat{A}_α^2 ($\because \sum_{\alpha} \hat{A}_\alpha^2 = 1$).
- Pick a random $i \in \alpha$.

For W:

- Consider table B.
- Pick $\beta \subseteq [m]$ w.p. \hat{B}_β^2 ($\because \sum_{\beta} \hat{B}_\beta^2 = 1$).
- Pick a random $j \in \beta$.

Note: For a probabilistic labeling, there exists a deterministic one, as good as its expectation.

(#1) implies that

$$- \text{w.p.} \geq \frac{\eta^2}{4},$$

$$|\alpha| \leq \pi(\beta).$$

$$|\beta| \leq \frac{1}{\varepsilon} \log(1/\eta).$$

- After picking $i_0 \in \alpha$, $\exists j_0 \in \beta$ s.t.

(as label)

$$\pi(j_0) = i_0$$

and $j_0 \in \beta$ is picked w.p. $\geq \varepsilon \log^{-1}(1/\eta)$.

(as label)

\therefore overall fraction of label cover edges satisfied is at least (in expectation)

$$\frac{\eta}{2}$$

$$\cdot \frac{\eta^2}{4}$$

$$\cdot \varepsilon \log^{-1}(1/\eta)$$

(v,w) "good"

(#1)

$j_0 \in \beta$ picked.

i.e. at least $\Omega(\varepsilon \eta^3 \log^{-1}(1/\eta))$.



Folding

- Note that we assumed that $\hat{A}_\alpha \neq 0$
only if $\alpha \neq \emptyset$.

- We can enforce the condition that

$$A(-x) = -A(x) \quad \forall x \in \{-1, 1\}^n.$$

Such A is called "folded".

Effectively the bits/variables $A(-x)$, $A(x)$
are declared as negations of
each other.

Exercise If A is folded (i.e. $A(-x) = -A(x)$)

then $\hat{A}_\alpha \neq 0 \implies |\alpha|$ is odd

(in particular $d \neq \emptyset$).

Effectively some equations of form

$$a \oplus b \oplus c = 0 \quad \text{are turned into}$$

$$a \oplus b \oplus c = 1.$$



To conclude

$\forall \epsilon, \eta > 0$, (constant)

Given instance of 3Lin

$$S: \begin{array}{l} \vdots \\ a \oplus b \oplus c = 1 \\ b \oplus d \oplus e = 0 \\ \vdots \end{array}$$

it is NP-hard to distinguish if

(YES) $\text{OPT}(S) \geq 1 - \epsilon$ or

(NO) $\text{OPT}(S) \leq \frac{1}{2} + \eta$.

Note: Imperfect completeness is necessary

Corollary Gap 3SAT $1 - \epsilon, \frac{7}{8} + \eta$ is NP-hard.